Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/698,999	MELTON ET AL.		
Examiner	Art Unit		
X. L. Bautista	2179		

SEARCHED				
Class	Subclass	Date	Examiner	
715	703,727	12/14/2006	ХВ	
	764,835			
	839,846			
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434	98			
368	10			
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705	2,3			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
715	703,835	12/14/2006	ХВ	
	839,846			
705	2,3			
700/236				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search	12/14/2006	ХВ		
Databases Searched: US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB				
Google.com				
IEEE Xplore				
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